Applicant(s)/Patent Under Application/Control No. Reexamination 09/940,866 HAYASHI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Katarzyna Wyrozebski 1714 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-Α В US-С US-US-D Ε US-F US-G US-Н US-USı US-J Κ US-L US-М US-**FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν JP 01138114 05-1989 JΡ Abstract only 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

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